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01/18/2001	Shunpei Yamazaki	740756-002249	6097
05/14/2004		EXAMINER	
NIXON PEABODY, LLP 401 9TH STREET, NW		BOOTH, RICHARD A	
		ART UNIT	PAPER NUMBER
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	01/18/2001 00 05/14/2004 ODY, LLP ET, NW	01/18/2001 Shunpei Yamazaki 00 05/14/2004 ODY, LLP ET, NW	01/18/2001 Shunpei Yamazaki 740756-002249 00 '05/14/2004 EXAM ODY, LLP ET, NW ART UNIT DC 20004-2128 2812

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)		
Office Action Summary	09/761,641	YAMAZAKI ET AL.		
ome Action Summary	Examiner	Art Unit		
The MANUALO DATE AND	Richard A. Booth	2812		
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the	correspondence address		
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply If NO period for reply is specified above, the maximum statutory period w. - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	6(a). In no event, however, may a reply be tin within the statutory minimum of thirty (30) day ill apply and will expire SIX (6) MONTHS from	nely filed s will be considered timely. the mailing date of this communication.		
Status				
1) Responsive to communication(s) filed on 03 Ma	av 2004			
2a) ☐ This action is FINAL . 2b) ☑ This action is non-final. 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is				
closed in accordance with the practice under Ex	v nade Quavio, 1025 C.D. 44, 45	secution as to the ments is		
	Parte Quayle, 1935 C.D. 11, 45	3 O.G. 213.		
Disposition of Claims				
 4) Claim(s) 1-14 is/are pending in the application. 4a) Of the above claim(s) is/are withdraw 5) Claim(s) is/are allowed. 6) Claim(s) 1-14 is/are rejected. 7) Claim(s) is/are objected to. 				
8) Claim(s) are subject to restriction and/or Application Papers	election requirement.			
9) The specification is objected to by the Examiner. 10) The drawing(s) filed on is/are: a) accept Applicant may not request that any objection to the drawing sheet(s) including the correction to the original transfer of the oath or declaration is objected to by the Example 11) The oath or declaration is objected to by the Example 11.	oted or b) objected to by the E awing(s) be held in abeyance. See n is required if the drawing(s) is obje	37 CFR 1.85(a).		
Priority under 35 U.S.C. § 119		100011 01 101111 1 1 0 1 1 1 2 .		
12) Acknowledgment is made of a claim for foreign part a) All b) Some * c) None of: 1. Certified copies of the priority documents to a copies of the priority documents to a copies of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the priority application from the Internation for a list of the certified copies of the certified copies of the priority application from the International Bureau (* See the attached detailed Office action for a list of the certified copies of the certif	nave been received. nave been received in Application of documents have been received PCT Rule 17.2(a)).	n No I in this National Stage		
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Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	4) Interview Summary (P Paper No(s)/Mail Date 5) Notice of Informal Pate 6) Other:	·		

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DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 1-3, 6-8, and 11 are rejected under 35 U.S.C. 103(a) as being unpatentable over Silver, U.S. Patent 5,104,818 in view of Yamazaki, U.S. Patent 4,727,044 and further in view of Chang, U.S. Patent 5,064,775 and Wolf et al., "Silicon Processing for the VLSI Era Volume 1: Process Technology".

Silver shows the invention substantially as claimed including a method of manufacturing a semiconductor device comprising: ion-doping an impurity

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element into a channel region, wherein said impurity element imparts p-type conductivity to said semiconductor film (see fig. 1C), wherein the concentration of said impurity element is 2×10^{17} atoms/cm³ after the step (see figs. 1c-1f and col. 2-lines 29-54).

Silver is applied as above but fails to expressly disclose the concentration of carbon, oxygen, and nitrogen of less than 3 x 10¹⁷ atoms/cm³, forming an insulating film over the semiconductor film, and ion-doping an impurity element into a channel region of the semiconductor film through the insulating film.

Yamazaki discloses forming a semiconductor film so that the oxygen, carbon, and nitrogen concentrations in the film are all less than 5 x 10¹⁸ atoms/cm³ in order to obtain a large drain current (see col. 8-lines 3-23). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Silver so as to form the semiconductor film with low oxygen, carbon, and nitrogen concentration levels as specified by Yamazaki because this will produce a transistor with good electrical characteristics. Furthermore, Chang discloses introducing boron 36 into a semiconductor film so that the boron implanted region becomes part of a channel region (see fig. 2 and col. 4-line 55 to col. 5-line 37), and Wolf et al. discloses that commonly in order to reduce damage to the semiconductor surface, layers are deliberately added, for instance, silicon oxide layers (see page 323, "Implanting Through Surface Layers"). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made

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to modify the process of Silver modified by Yamazaki so as to implant boron into the channel region through the silicon

oxide insulating film because this will allow for more independent control of the threshold voltage while at the same time reducing substrate damage.

Regarding the doping gases being used, official notice was taken regarding this fact in the office action mailed 10-10-02, and therefore this limitation is taken to be admitted prior art.

Claims 4-5 rejected under 35 U.S.C. 103(a) as being unpatentable over Silver, U.S. Patent 5,104,818 in view of Yamazaki, U.S. Patent 4,727,044 and further in view of Chang, U.S. Patent 5,064,775 and Wolf et al., "Silicon Processing for the VLSI Era Volume 1: Process Technology" as applied to claims 1-3, 6-8, and 11 above, and further in view of Zhang et al., U.S. Patent 5,904,509.

Silver, Yamazaki, Chang, and Wolf et al. are applied as above but fail to expressly disclose performing implantation without mass separation and through an insulating film.

Zhang et al. discloses performing plasma doping without mass separation and implanting these ions into a semiconductor film through an insulating film (see col. 8-line 59 to col. 9-line 2). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Silver modified by Yamazaki, Chang, and Wolf et al. so as to conduct the implantation using plasma doping through an insulating film since

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plasma doping is shown to be a suitable method of injecting ions into a semiconductor and because it is well known to use screen oxides during implantation in order to reduce damage to the substrate.

Claims 9-10 and 12-14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Silver, U.S. Patent 5,104,818 in view of Yamazaki, U.S. Patent 4,727,044 and further in view of Chang, U.S. Patent 5,064,775 and Wolf et al., "Silicon Processing for the VLSI Era Volume 1: Process Technology" as applied to claims 1-3, 6-8, and 11 above, and further in view of Miyasaka, U.S. Patent 6,455,360

Silver, Yamazaki, Chang, and Wolf et al. are applied as above but fail to expressly disclose wherein an impurity element imparting p-type conductivity is conducted with a gas of diborane diluted with hydrogen from 0.5% to either 1 or 5 percent so that the concentration of hydrogen is 1 x 10¹⁹ atoms/cm³ or less.

Miyasaka discloses performing a doping step using diborane diluted with hydrogen at a concentration of 0.1 to 10% (see col. 22-lines 37-41). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the process of Silver modified by Yamazaki, Chang, and Wolf et al. so as to include a diborane gas diluted with hydrogen because Miyasaka shows this to be a suitable combination to form doped region in thin film structures.

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R sponse to Arguments

Applicant's arguments with respect to claims 1-14 have been considered but are moot in view of the new ground(s) of rejection.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Richard A. Booth whose telephone number is (571) 272-1668. The examiner can normally be reached on Monday-Thursday from 7:30-6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Niebling can be reached on (571) 272-1679. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Richard A. Booth Primary Examiner

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